


<b>Search Notes</b>  	<b>Application/Control No.</b>  10608518	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  Layno, Carl H	<b>Art Unit</b>  3766

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPGPUB, USOCR, EPO, JPO, IBM_TDB, DERWENT). Updated text search. See Search History for terms used.	09/11/2006	CHL
EAST (USPAT, USPGPUB, USOCR, EPO, JPO, IBM_TDB, DERWENT, FPRS). Updated text search. See Search History for terms used.	12/05/2006	CHL

INTERFERENCE SEARCH			
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	PGPUB text search. See Interference Search Printout.	12/05/2006	CHL